

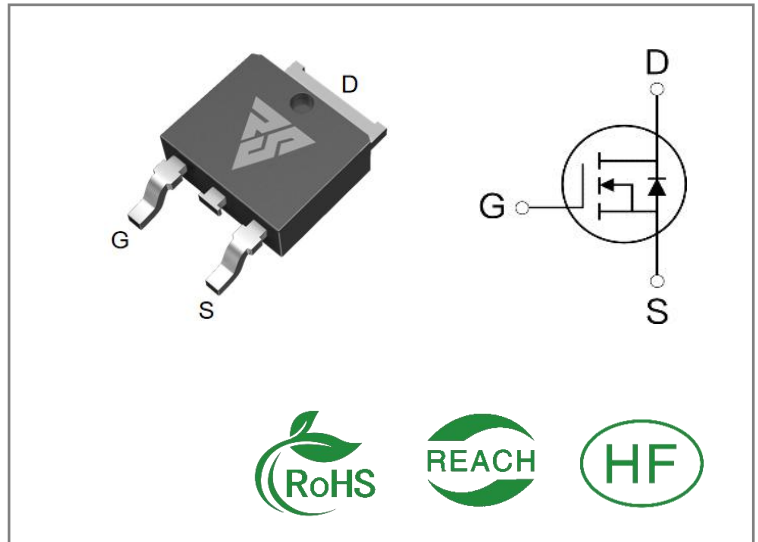
| ID | $R_{DS(ON)}$ (Typ) | VDSS |
|----|--------------------|------|
| 9A | 420mΩ | 800V |

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

| Part Number | Package | Marking | Packing | Qty. |
|-------------|---------|-----------|-----------|----------|
| RS80R500D | T0-252 | RS80R500D | Tape&reel | 2500 PCS |

Absolute Maximum Ratings $T_c = 25^\circ\text{C}$ unless otherwise specified

| Symbol | Parameter | RS80R500D | Units |
|-------------|---|------------|------------------|
| VDSS | Drain-to-Source Voltage | 800 | V |
| ID | Continuous Drain Current $T_C = 25^\circ\text{C}$ | 9 | A |
| ID | Continuous Drain Current $T_C = 100^\circ\text{C}$ | 5.5 | |
| IDM | Pulsed Drain Current (Note*1) | 27 | |
| PD | Power Dissipation | 521 | W |
| VGS | Gate- to- Source Voltage | ± 30 | V |
| EAS | Single Pulse Avalanche Energy $L = 10\text{mH}, V_{DS} = 50\text{V}, R_G = 25\ \Omega, T_C = 25^\circ\text{C}$ | 270 | mJ |
| dv/dt | MOSFET dv/ dt ruggedness $V_{DS} = 0 \dots 400\text{V}$ | 50 | V/ns |
| dv/dt | Reverse diode dv/dt $V_{DS} = 0 \dots 400\text{V}, T_j = 25^\circ\text{C}, I_{SD} \leq I_D$ | 15 | V/ns |
| TL TPKG | Maximum Temperature for Soldering | 300 260 | $^\circ\text{C}$ |
| | Leads at 0.063in(1.6mm)from Case for 10 seconds | | |
| | Package Body for 10 seconds | | |
| TJ and TSTG | Operating Junction and Storage Temperature Range | -55 to 150 | |

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the " Absolute Maximum Ratings" Table may cause permanent damage to the device.

Thermal Resistance

| Symbol | Parameter | RS80R500D | Units | Test Conditions |
|---------------|---------------------|-----------|-------------------------------|---|
| R θ JC | Junction-to-Case | 4.1 | $^{\circ}\text{C} / \text{W}$ | Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\text{C}$ |
| R θ JA | Junction-to-Ambient | 80 | | 1 cubic foot chamber, free air. |

OFF Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise specified

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|--------|-------------------------------------|------|------|------|---------------|--|
| BVDSS | Drain- to- source Breakdown Voltage | 800 | -- | -- | V | $V_{GS}=0\text{V}, I_D=250\mu\text{A}$ |
| IDSS | Drain- to- Source Leakage Current | -- | -- | 1 | μA | $V_{DS}=800\text{V}, V_{GS}=0\text{V}$ |
| IGSS | Gate- to- Source Forward Leakage | -- | -- | 100 | nA | $V_{GS}=30\text{V}, V_{DS}=0\text{V}$ |
| | Gate- to- Source Reverse Leakage | -- | -- | -100 | | $V_{GS}=-30\text{V}, V_{DS}=0\text{V}$ |

ON Characteristics $T_J = 25^{\circ}\text{C}$ unless otherwise specified

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|---------|--|------|------|------|------------|--------------------------------------|
| RDS(on) | Static Drain- to- Source On-Resistance(Note*2) | -- | 420 | 500 | m Ω | $V_{GS}=10\text{V}, I_D=4.5\text{A}$ |
| VGS(TH) | Gate Threshold Voltage | 2.5 | -- | 4.5 | V | $V_{GS}=V_{DS}, I_D=250\mu\text{A}$ |

Resistive Switching Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|---------|----------------------|------|------|------|-------|---|
| td(ON) | Turn- on Delay Time | -- | 28 | -- | nS | $V_{DS}=400\text{V}$ $I_D=9\text{A}$ $R_G=25\Omega$ |
| trise | Rise Time | -- | 34 | -- | | |
| td(OFF) | Turn- OFF Delay Time | -- | 100 | -- | | |
| tfall | Fall Time | -- | 28 | -- | | |

Dynamic Characteristics Essentially independent of operating temperature

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|--------|---------------------------------|------|------|------|-------|--------------------------------|
| Ciss | Input Capacitance | -- | 1099 | -- | pF | VGS=0V VDS=100V f=1.0MHz |
| Coss | Output Capacitance | -- | 52 | -- | | |
| Crss | Reverse Transfer Capacitance | -- | 1 | -- | | |
| Qg | Total Gate Charge | -- | 24.6 | -- | nC | VDS=400V ID=9A VGS=10V |
| Qgs | Gate- to- Source Charge | -- | 5.6 | -- | | |
| Qgd | Gate-to-Drain(" Miller") Charge | -- | 9 | -- | | |

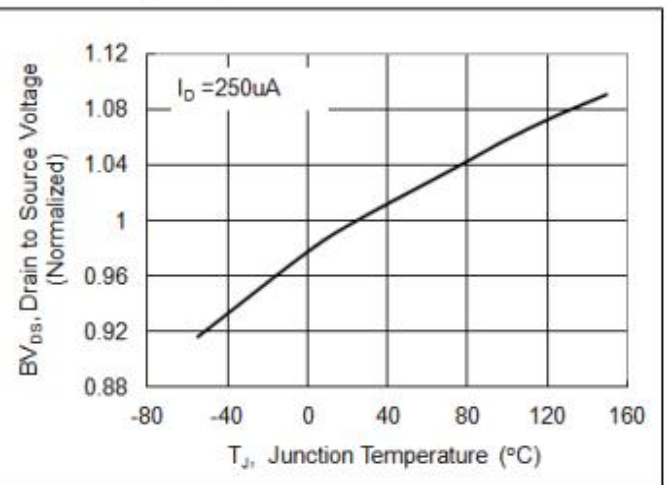
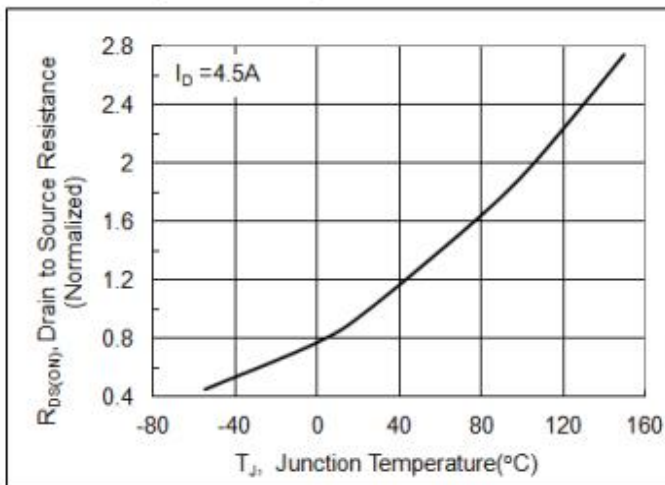
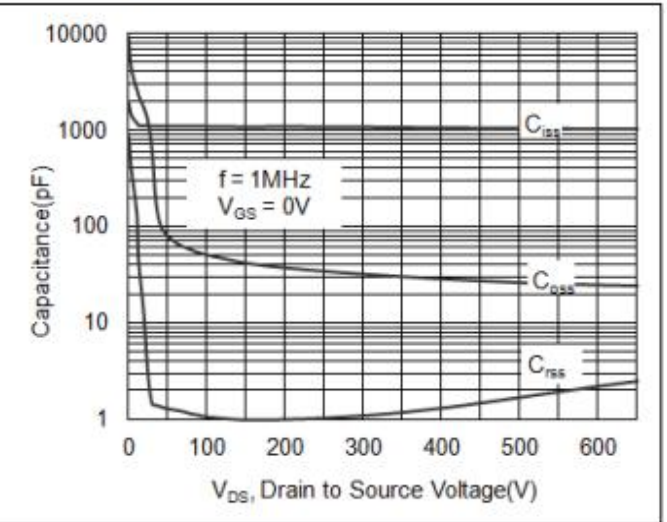
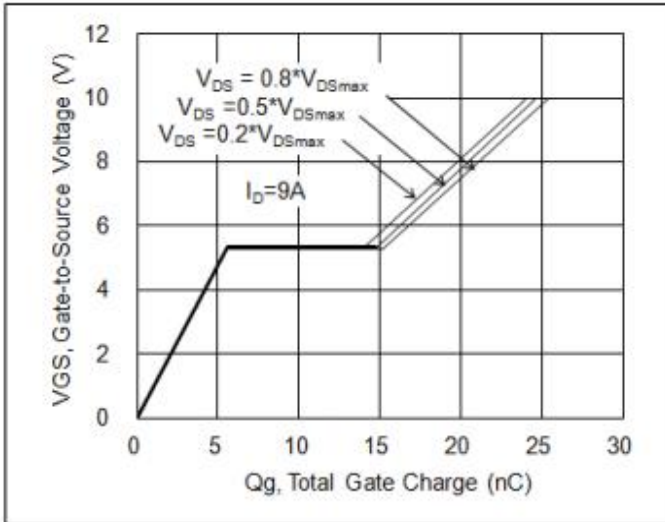
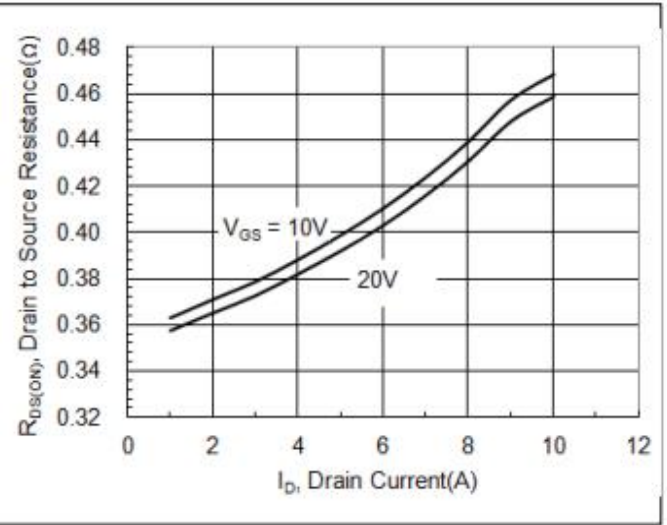
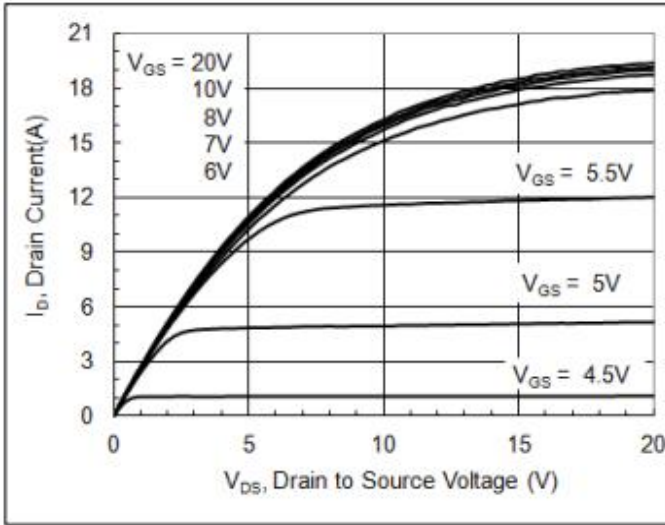
Source- Drain Diode Characteristics

| Symbol | Parameter | Min. | Typ. | Max. | Units | Test Conditions |
|--------|---------------------------|------|------|------|-------|------------------------------------|
| IS | Continuous Source Current | -- | -- | 9 | A | Integral pn- diode in MOSFET |
| ISM | Maximum Pulsed Current | -- | -- | 27 | A | |
| VSD | Diode Forward Voltage | -- | -- | 1.3 | V | IS=9A,VGS=0V |
| trr | Reverse Recovery Time | -- | 258 | -- | nS | VR=100V IS=9A,di/dt=100A /μs |
| Qrr | Reverse Recovery Charge | -- | 3.15 | -- | μC | |

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 2%

Typical Feature Curve



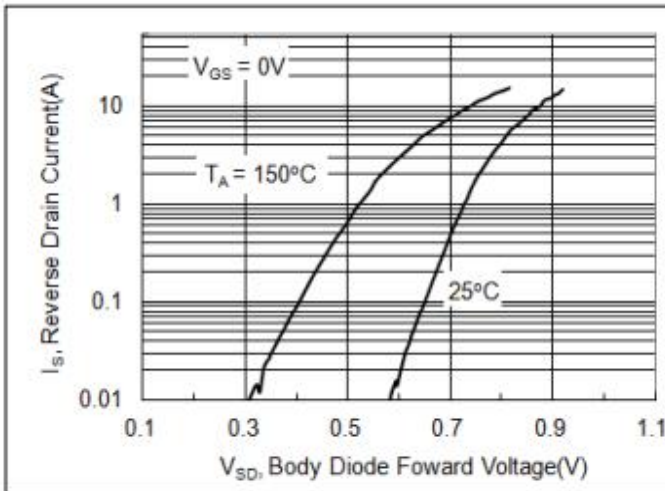


Fig 7 . Forward characteristics of reverse diode

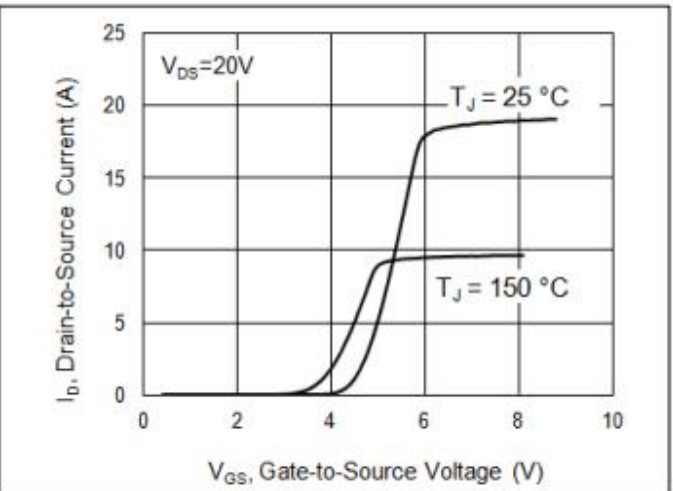


Fig 8 . Transfer characteristics

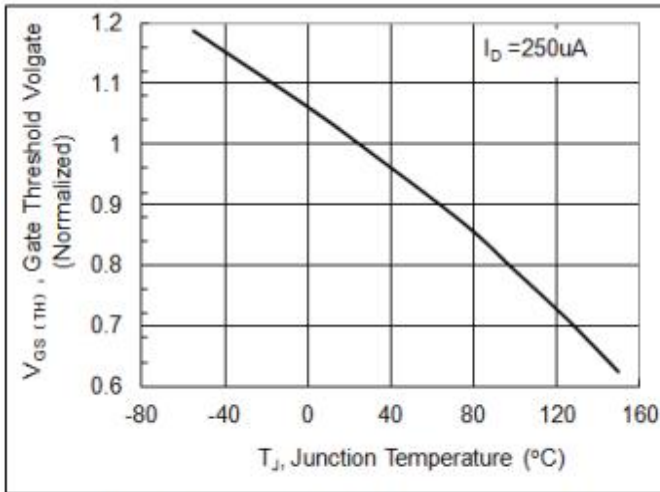


Fig 9 . $V_{GS(th)}$ vs junction temperature

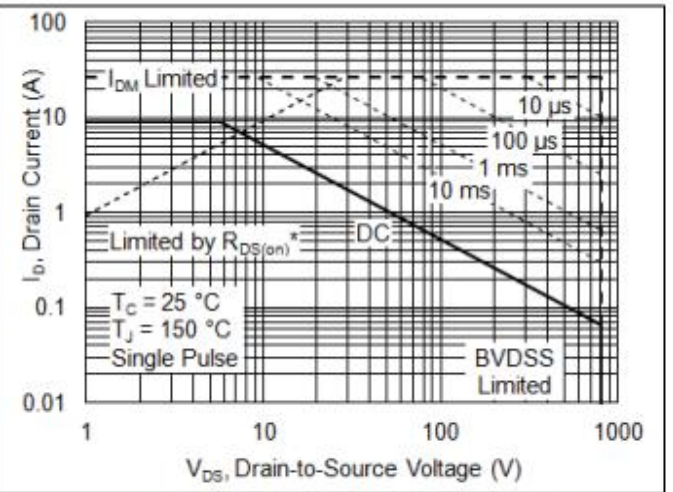


Fig 10. Safe operating area(TO-220F)

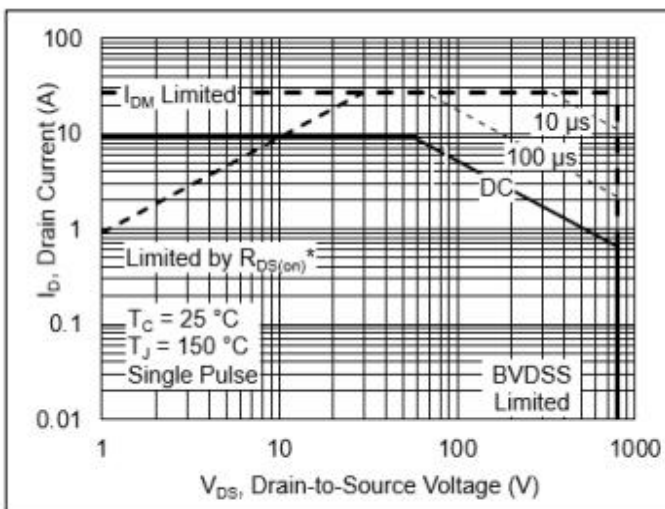


Fig 11 . Safe operating area(TO-251&TO-252)

Test Circuits and Waveforms

Figure A: Gate Charge Test Circuit and Waveform

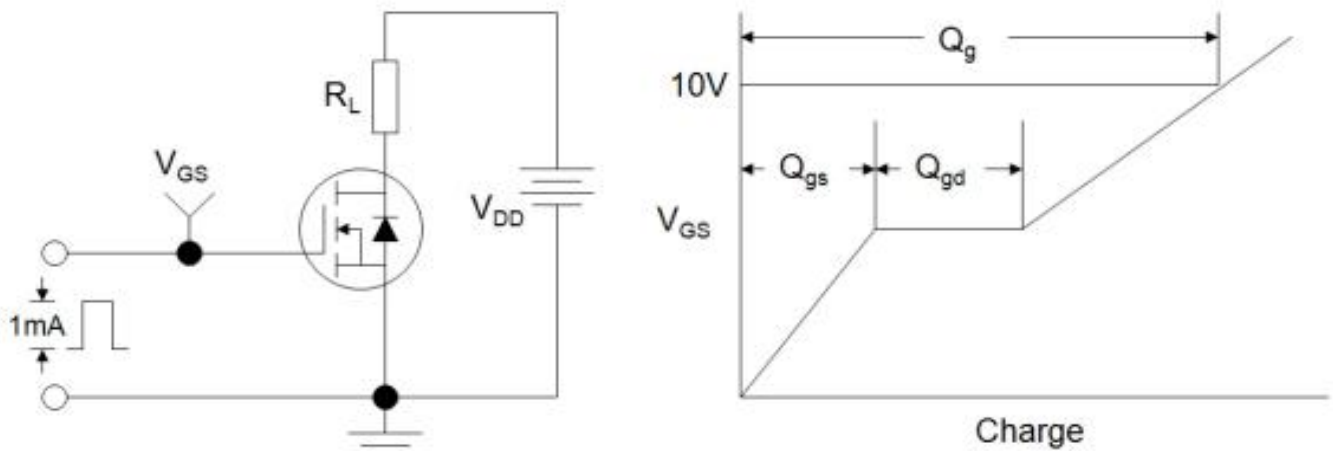


Figure B: Resistive Switching Test Circuit and Waveform

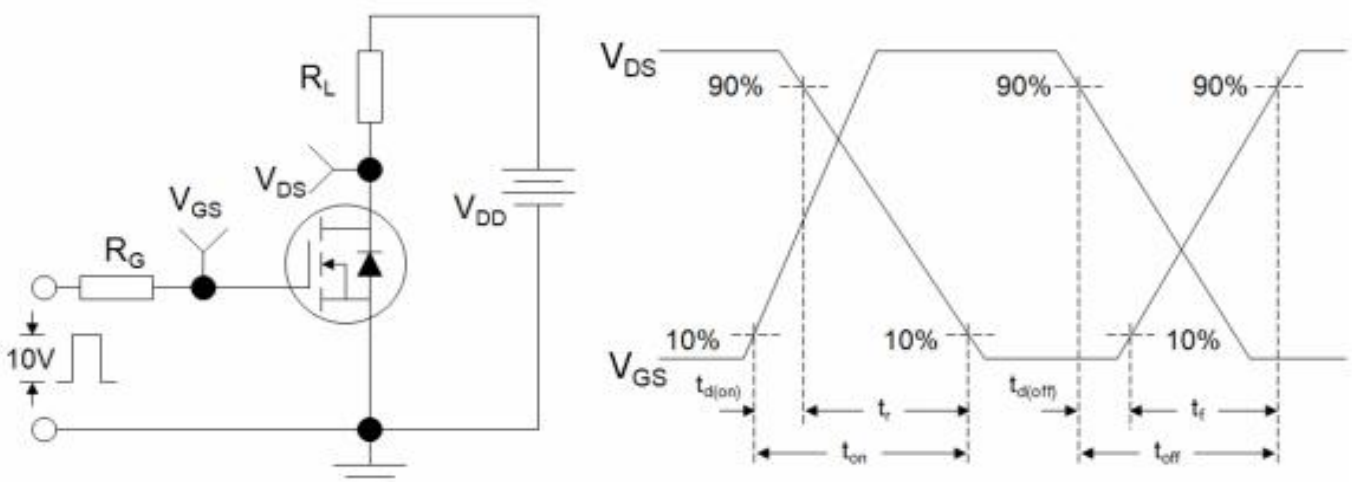
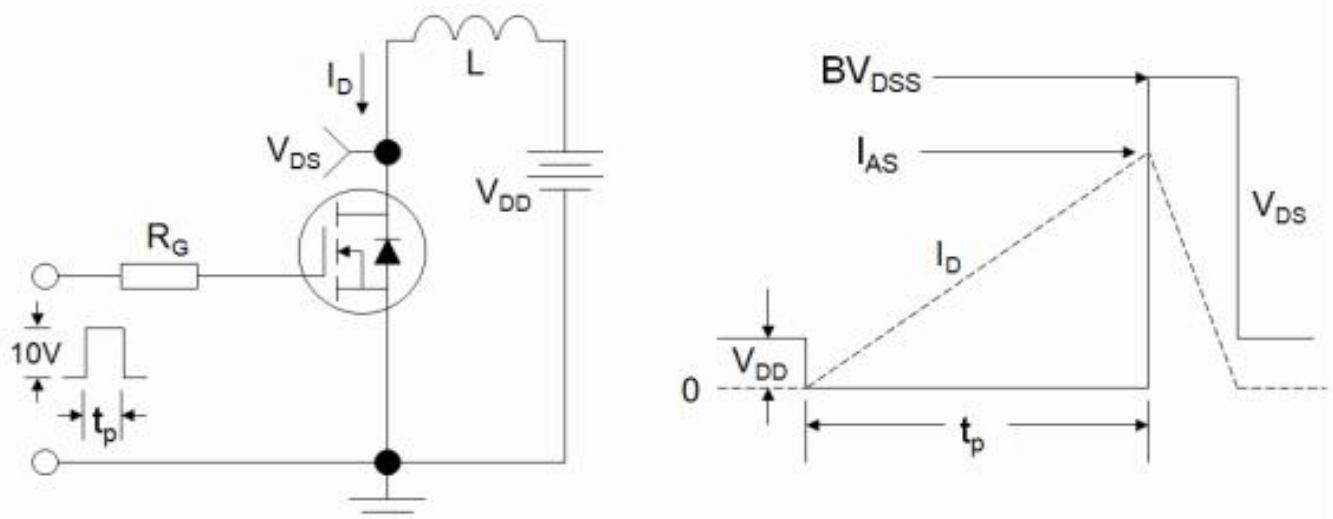
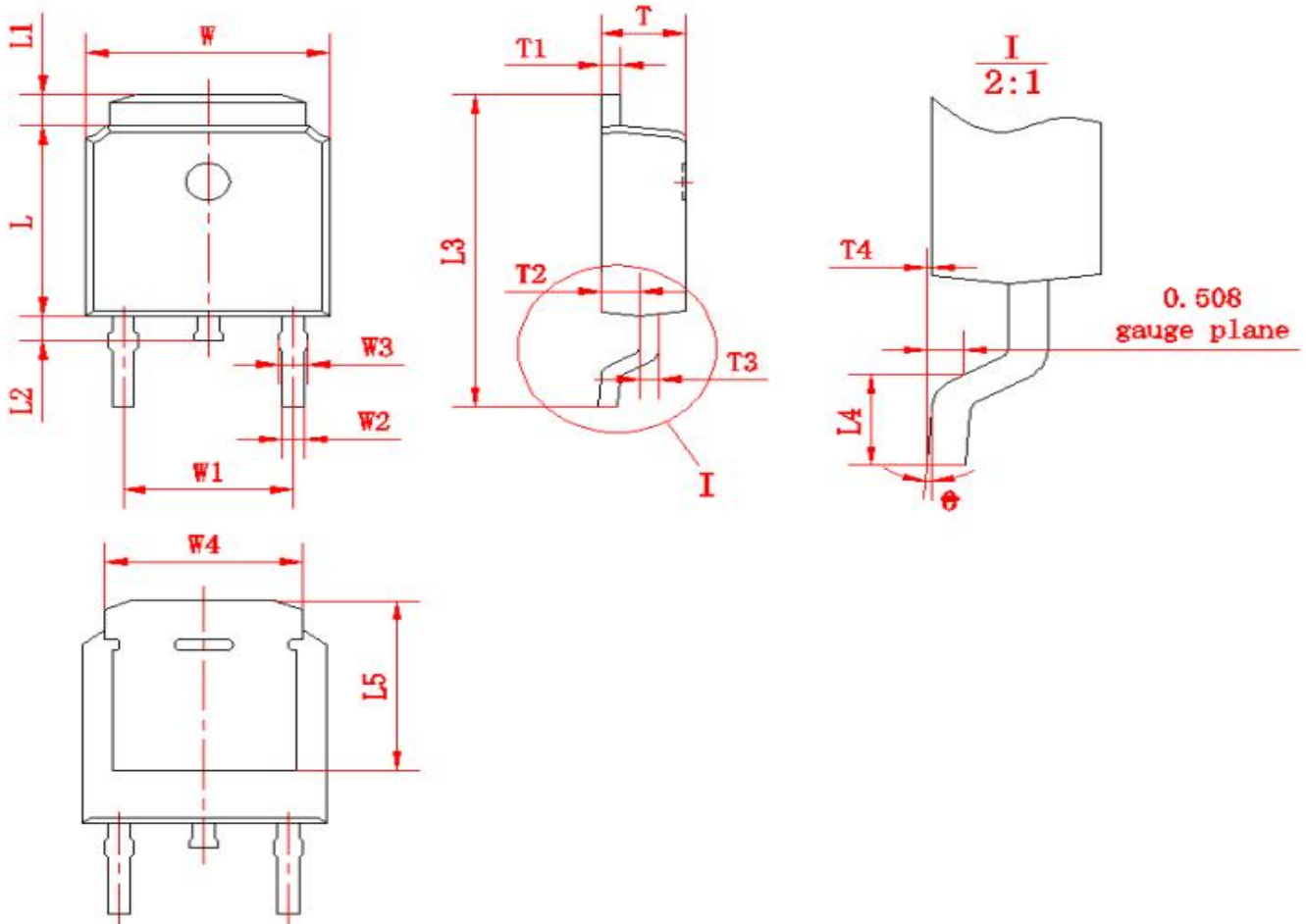


Figure C: Unclamped Inductive Switching Test Circuit and Waveform



Package outline drawing(TO-252 Unit: mm)



| 符号 | 尺寸 | | 符号 | 尺寸 | | 符号 | 尺寸 | |
|----|---------|------|----|--------|-------|----|------|------|
| | Min | Max | | Min | Max | | Min | Max |
| W | 6.50 | 6.70 | L1 | 0.80 | 1.20 | T1 | 0.48 | 0.58 |
| W1 | (4.572) | | L2 | 0.60 | 1.00 | T2 | 0.95 | 1.15 |
| W2 | 0.6 | 0.8 | L3 | 9.70 | 10.30 | T3 | 0.48 | 0.58 |
| W3 | 0.68 | 0.88 | L4 | 1.30 | 1.70 | T4 | 0.00 | 0.12 |
| W4 | (5.3) | | L5 | (5.20) | | 0 | 0 | 8 |
| L | 6.00 | 6.20 | T | 2.20 | 2.40 | | | |

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